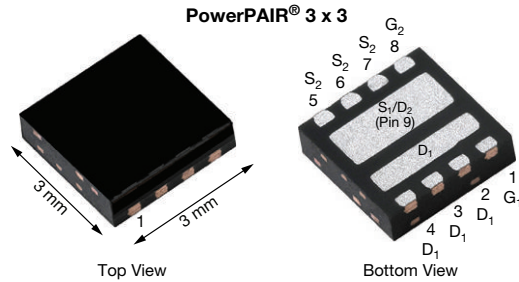


Dual N-Channel 30 V (D-S) MOSFETs



FEATURES

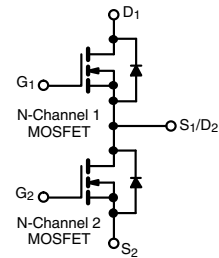
- TrenchFET® Gen IV power MOSFETs
- 100 % R_G and UIS tested
- PowerPAIR® integrated half-bridge MOSFET power stage
- Optimized Q_{gd}/Q_{gs} ratio improves switching characteristics
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



RoHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

- CPU core power
- Computer / server peripherals
- POL
- Synchronous buck converter
- Telecom DC/DC



PRODUCT SUMMARY		
	CHANNEL-1	CHANNEL-2
V _{DS} (V)	30	30
R _{DS(on)} max. (Ω) at V _{GS} = 10 V	0.092	0.005
R _{DS(on)} max. (Ω) at V _{GS} = 4.5 V	0.0155	0.0075
Q _g typ. (nC)	3.7	6.3
I _D (A) ^a	33.6	63
Configuration	Dual	

ORDERING INFORMATION	
Package	PowerPAIR 3 x 3
Lead (Pb)-free and halogen-free	SiZ340DDT-T1-GE3

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)				
PARAMETER	SYMBOL	CHANNEL-1	CHANNEL-2	UNIT
Drain-source voltage	V _{DS}	30	30	V
Gate-source voltage	V _{GS}	+20, -16	+20, -16	
Continuous drain current (T _J = 150 °C)	I _D	T _C = 25 °C	33.6	A
		T _C = 70 °C	26.9	
		T _A = 25 °C	15.8 ^{b, c}	
		T _A = 70 °C	12.6 ^{b, c}	
Pulsed drain current (100 μs pulse width)	I _{DM}	100	150	W
Continuous source drain diode current	I _S	T _C = 25 °C	13.9	
		T _A = 25 °C	3.1 ^{b, c}	
Single pulse avalanche current	I _{AS}	10	15	
Single pulse avalanche energy	E _{AS}	5	11	
Maximum power dissipation	P _D	T _C = 25 °C	16.7	W
		T _C = 70 °C	10.7	
		T _A = 25 °C	3.7 ^{b, c}	
		T _A = 70 °C	2.4 ^{b, c}	
Operating junction and storage temperature range	T _J , T _{stg}	-55 to +150		°C
Soldering recommendations (peak temperature) ^d		260		

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	CHANNEL-1		CHANNEL-2		UNIT
		TYP.	MAX.	TYP.	MAX.	
Maximum junction-to-ambient ^{b, f}	R _{thJA}	27	34	24	30	°C/W
Maximum junction-to-case (drain)	R _{thJC}	6	7.5	3.2	4	

Notes

- T_C = 25 °C
- Surface mounted on 1" x 1" FR4 board
- t = 10 s
- See solder profile (www.vishay.com/doc?73257). The PowerPAIR is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components
- Maximum under steady state conditions is 69 °C/W for channel-1 and 64 °C/W for channel-2



SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	Ch-1	30	-	-	V
		$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	Ch-2	30	-	-	
V_{DS} Temperature coefficient	$\Delta V_{DS}/T_J$	$I_D = 10\text{ mA}$	Ch-1	-	21	-	mV/ $^\circ\text{C}$
			Ch-2	-	23.1	-	
$V_{GS(th)}$ Temperature coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250\text{ }\mu\text{A}$	Ch-1	-	-4.0	-	
			Ch-2	-	-4.9	-	
Gate threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	Ch-1	1.1	-	2.4	V
		$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	Ch-2	1.1	-	2.4	
Gate source leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = +20\text{ V} / -16\text{ V}$	Ch-1	-	-	100	nA
		$V_{DS} = 0\text{ V}, V_{GS} = +20\text{ V} / -16\text{ V}$	Ch-2	-	-	100	
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$	Ch-1	-	-	1	μA
		$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$	Ch-2	-	-	1	
		$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$	Ch-1	-	-	10	
		$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$	Ch-2	-	-	10	
Drain-source on-state resistance ^b	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 10\text{ A}$	Ch-1	-	0.0075	0.0092	Ω
		$V_{GS} = 10\text{ V}, I_D = 20\text{ A}$	Ch-2	-	0.0041	0.005	
		$V_{GS} = 4.5\text{ V}, I_D = 7\text{ A}$	Ch-1	-	0.012	0.0155	
		$V_{GS} = 4.5\text{ V}, I_D = 15\text{ A}$	Ch-2	-	0.006	0.0075	
Forward transconductance ^b	g_{fs}	$V_{GS} = 10\text{ V}, I_D = 10\text{ A}$	Ch-1	-	23	-	S
		$V_{GS} = 10\text{ V}, I_D = 10\text{ A}$	Ch-2	-	55	-	
Dynamic ^a							
Input capacitance	C_{iss}	Channel-1 $V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, f = 1\text{ MHz}$ Channel-2 $V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, f = 1\text{ MHz}$	Ch-1	-	500	-	pF
			Ch-2	-	960	-	
Output capacitance	C_{oss}		Ch-1	-	235	-	
			Ch-2	-	420	-	
Reverse transfer capacitance	C_{rss}		Ch-1	-	30	-	
			Ch-2	-	25	-	
C_{rss}/C_{iss} ratio			Ch-1	-	0.062	0.12	
			Ch-2	-	0.033	0.066	
Total gate charge	Q_g	$V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, I_D = 15\text{ A}$	Ch-1	-	8.4	12.6	nC
		$V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, I_D = 20\text{ A}$	Ch-2	-	14	21	
		$V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 15\text{ A}$	Ch-1	-	4.0	6.0	
		$V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 20\text{ A}$	Ch-2	-	6.3	9.5	
Gate-source charge	Q_{gs}	Channel-1 $V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 15\text{ A}$	Ch-1	-	2.2	-	
			Ch-2	-	3.5	-	
Gate-drain charge	Q_{gd}	Channel-2 $V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 20\text{ A}$	Ch-1	-	1.0	-	
			Ch-2	-	1.3	-	
Output charge	Q_{oss}	$V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V}$	Ch-1	-	5.7	-	
			Ch-2	-	11	-	
Gate resistance	R_g	$f = 1\text{ MHz}$	Ch-1	0.2	1.2	2	Ω
			Ch-2	0.2	1.1	2	



SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Dynamic ^a							
Turn-on delay time	$t_{d(on)}$	Channel-1 $V_{DD} = 15\text{ V}, R_L = 1.5\ \Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\ \Omega$	Ch-1	-	10	20	ns
			Ch-2	-	10	20	
Rise time	t_r		Ch-1	-	20	40	
			Ch-2	-	5	10	
Turn-off delay time	$t_{d(off)}$	Channel-2 $V_{DD} = 15\text{ V}, R_L = 1.5\ \Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\ \Omega$	Ch-1	-	13	25	
			Ch-2	-	16	33	
Fall time	t_f		Ch-1	-	5	10	
			Ch-2	-	5	10	
Turn-on delay time	$t_{d(on)}$	Channel-1 $V_{DD} = 15\text{ V}, R_L = 1.5\ \Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\ \Omega$	Ch-1	-	12	25	
			Ch-2	-	15	30	
Rise time	t_r		Ch-1	-	100	200	
			Ch-2	-	80	160	
Turn-off delay time	$t_{d(off)}$	Channel-2 $V_{DD} = 15\text{ V}, R_L = 1.5\ \Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\ \Omega$	Ch-1	-	10	20	
			Ch-2	-	13	30	
Fall time	t_f		Ch-1	-	10	20	
			Ch-2	-	7	15	
Drain-Source Body Diode Characteristics							
Continuous source-drain diode current	I_S	$T_C = 25\text{ }^\circ\text{C}$	Ch-1	-	-	13.9	A
			Ch-2	-	-	26	
Pulse diode forward current ($t = 100\ \mu\text{s}$)	I_{SM}		Ch-1	-	-	100	
			Ch-2	-	-	150	
Body diode voltage	V_{SD}	$I_S = 8\text{ A}, V_{GS} = 0\text{ V}$ $I_S = 10\text{ A}, V_{GS} = 0\text{ V}$	Ch-1	-	0.83	1.2	V
			Ch-2	-	0.80	1.2	
Body diode reverse recovery time	t_{rr}		Ch-1	-	15	30	ns
			Ch-2	-	21	40	
Body diode reverse recovery charge	Q_{rr}	Channel-1 $I_F = 10\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$	Ch-1	-	4	10	nC
			Ch-2	-	9	18	
Reverse recovery fall time	t_a	Channel-2 $I_F = 10\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$	Ch-1	-	7.5	-	ns
			Ch-2	-	9	-	
Reverse recovery rise time	t_b		Ch-1	-	7.5	-	
			Ch-2	-	12	-	

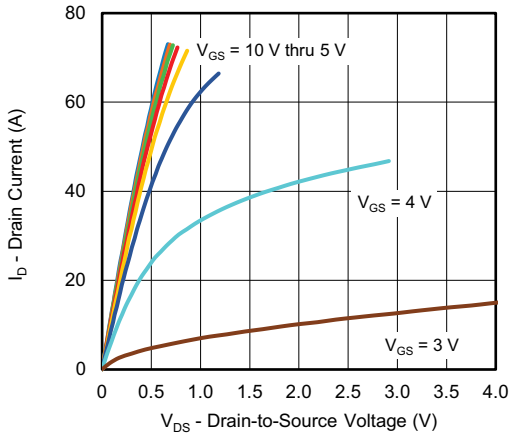
Notes

- a. Guaranteed by design, not subject to production testing
- b. Pulse test; pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$

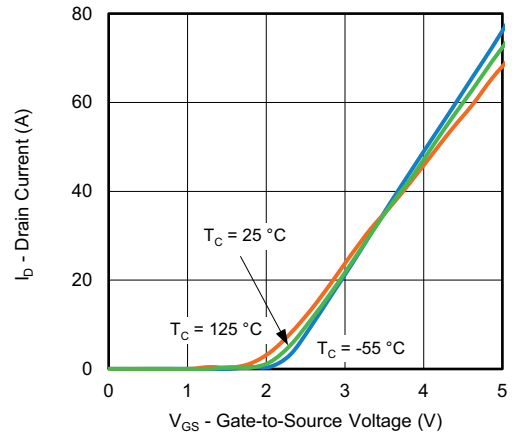
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



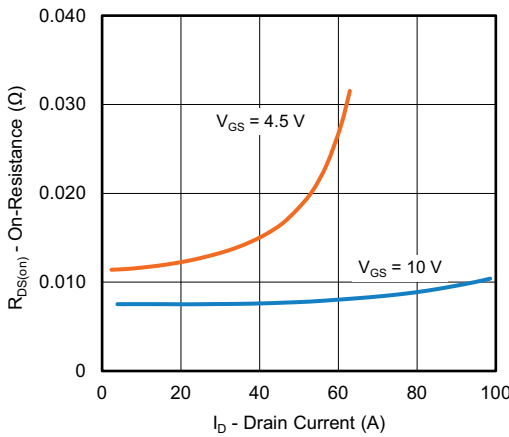
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



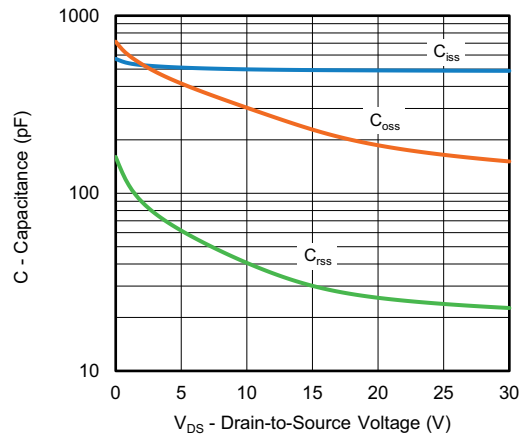
Output Characteristics



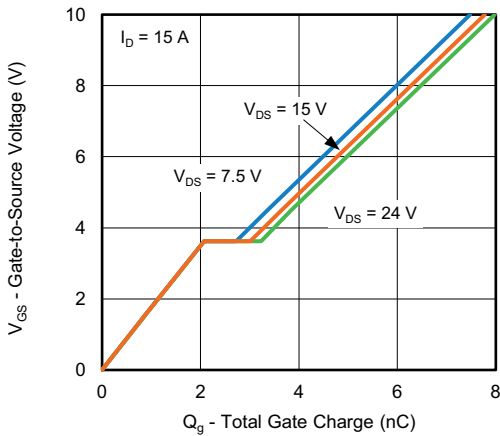
Transfer Characteristics



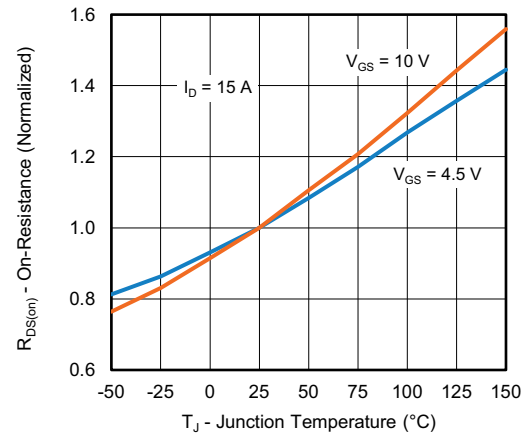
On-Resistance vs. Drain Current



Capacitance



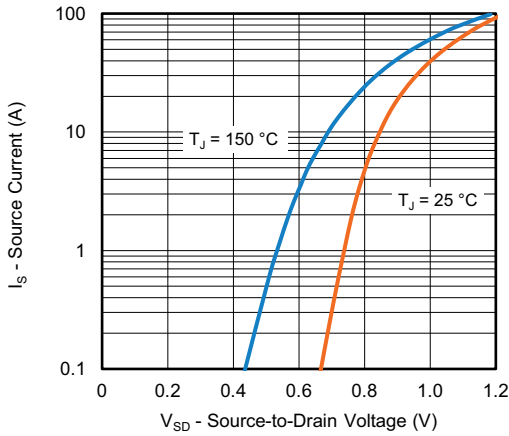
Gate Charge



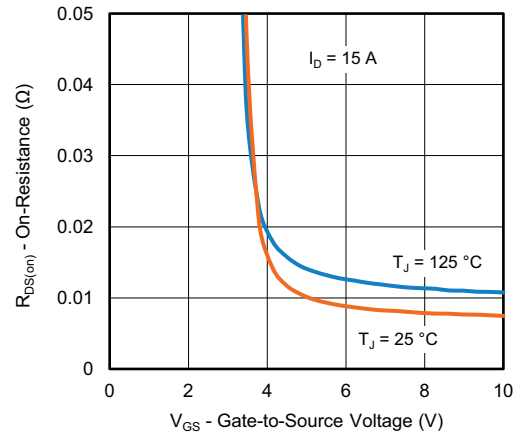
On-Resistance vs. Junction Temperature



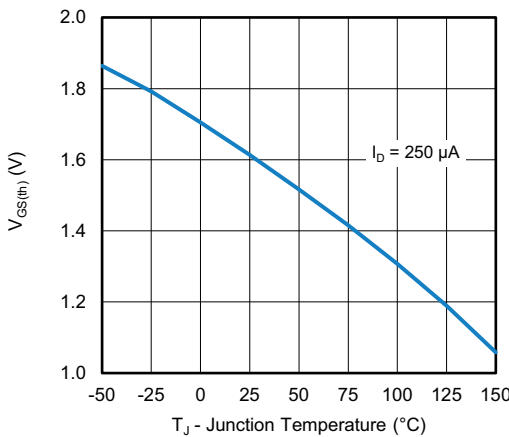
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



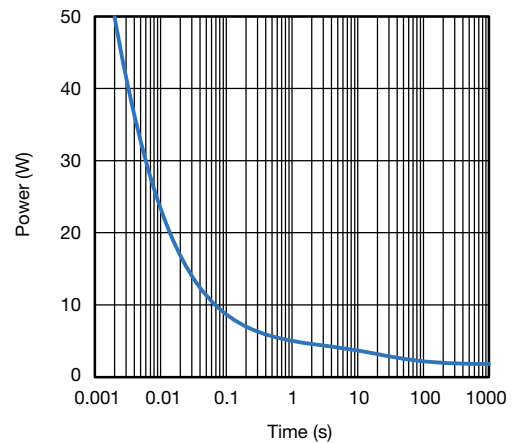
Source-Drain Diode Forward Voltage



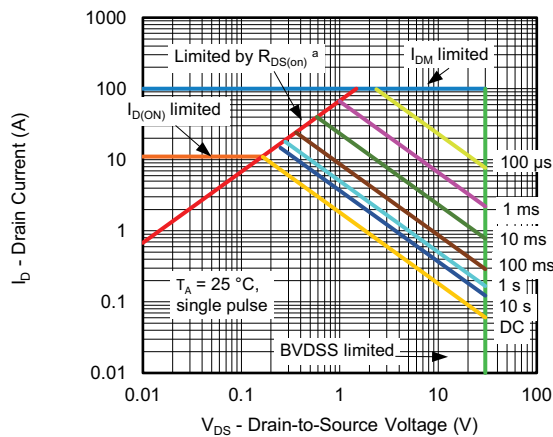
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient



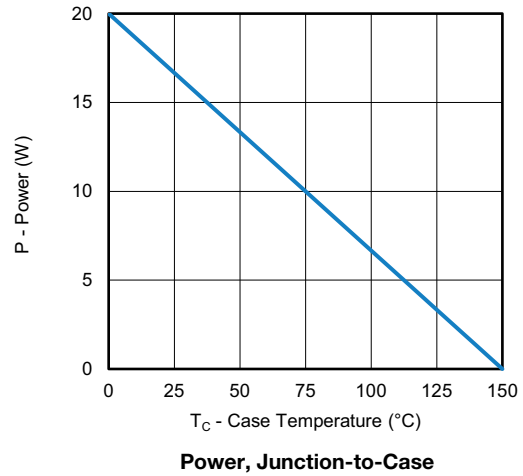
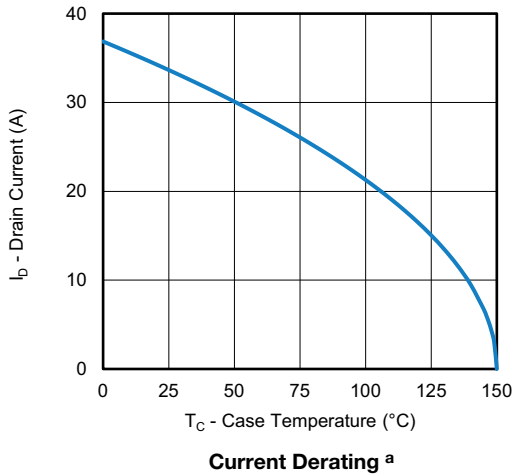
Safe Operating Area, Junction-to-Ambient

Note

a. $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified



CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

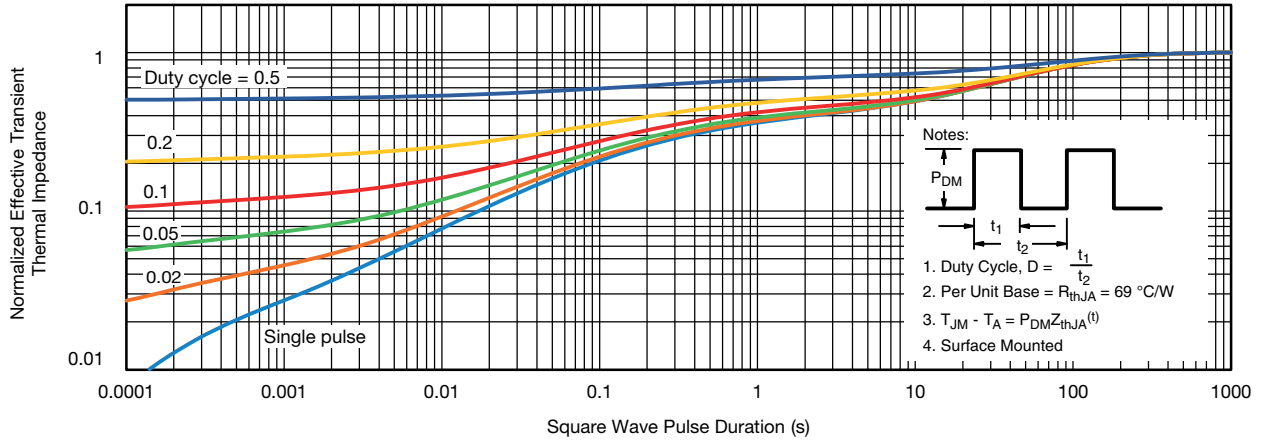


Note

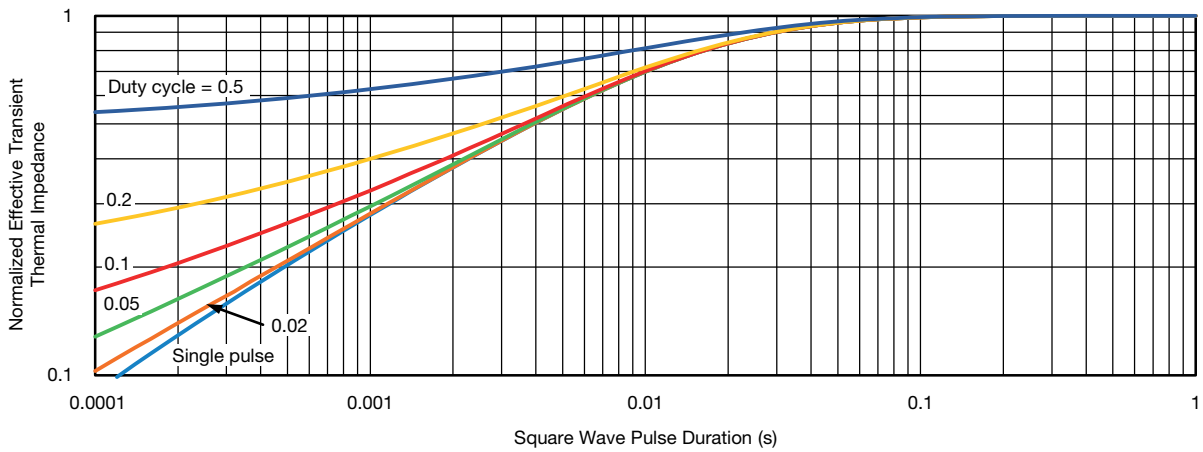
- a. The power dissipation P_D is based on T_J max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



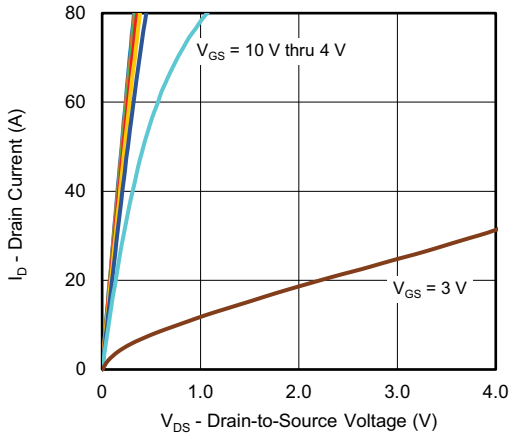
Normalized Thermal Transient Impedance, Junction-to-Ambient



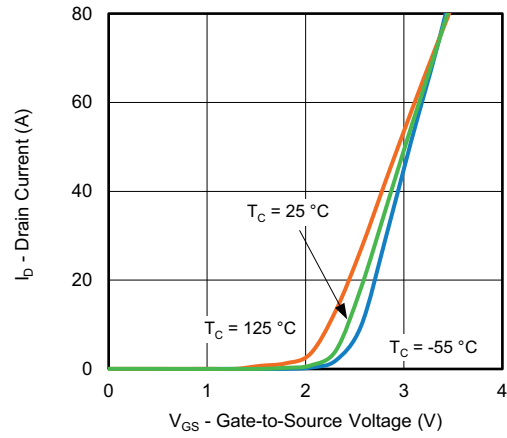
Normalized Thermal Transient Impedance, Junction-to-Case



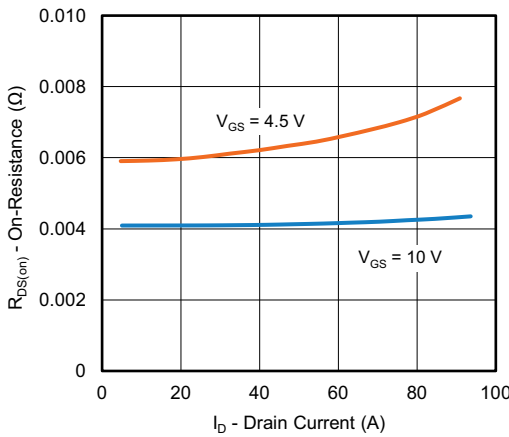
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



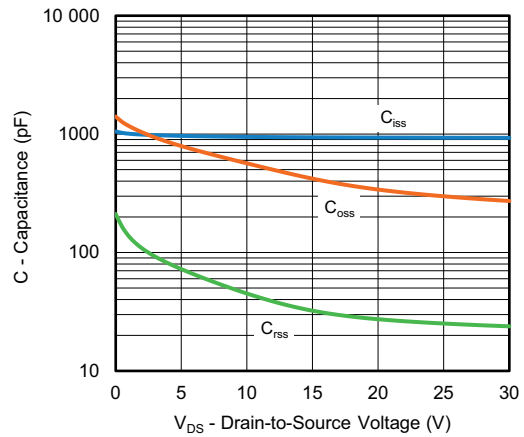
Output Characteristics



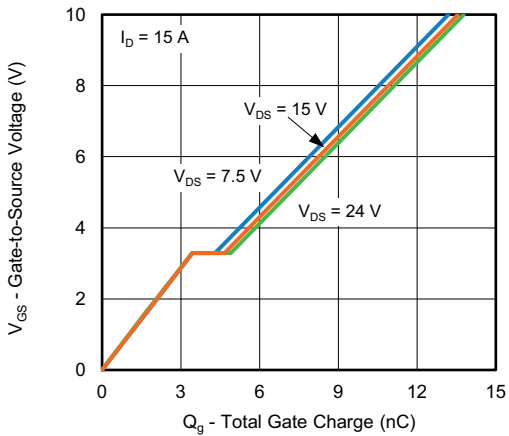
Transfer Characteristics



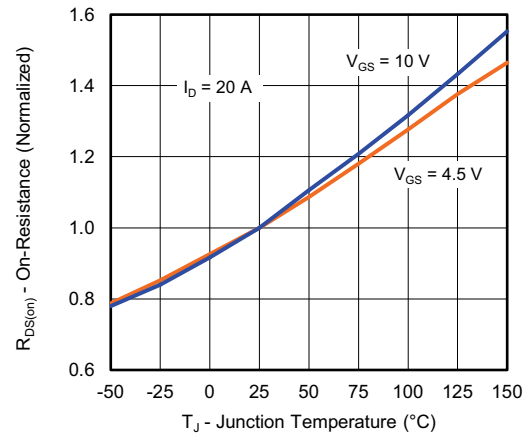
On-Resistance vs. Drain Current



Capacitance



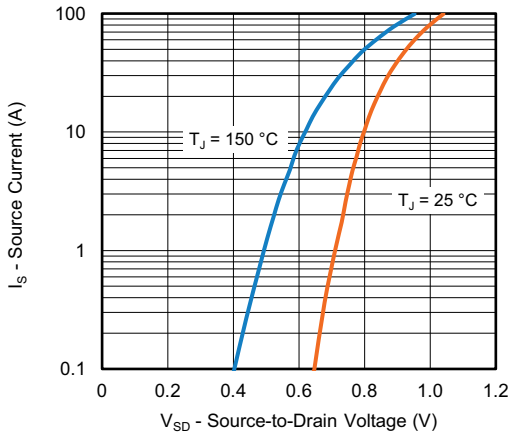
Gate Charge



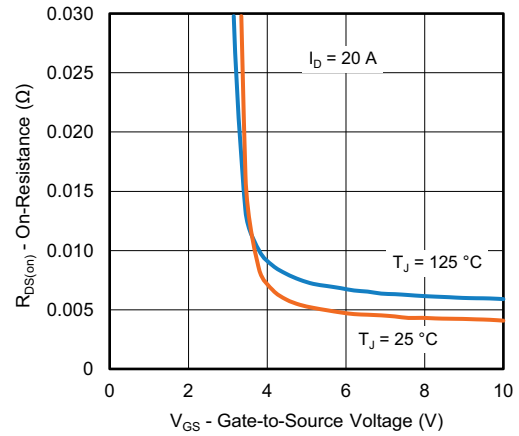
On-Resistance vs. Junction Temperature



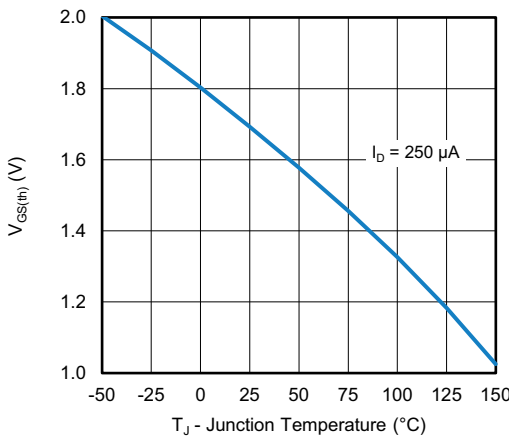
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



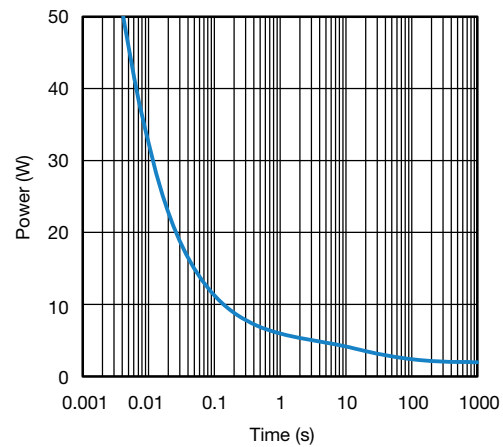
Source-Drain Diode Forward Voltage



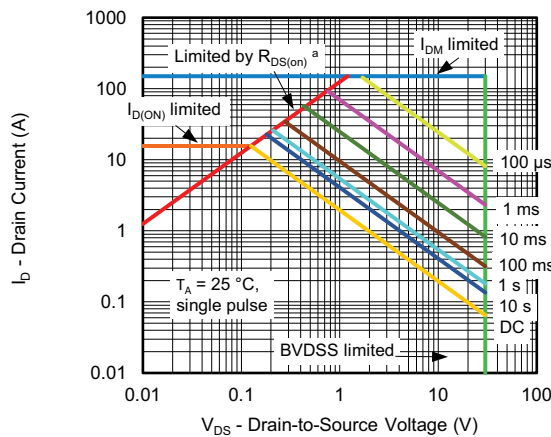
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient



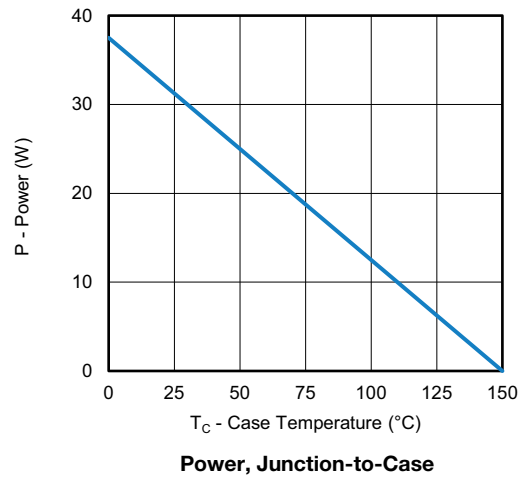
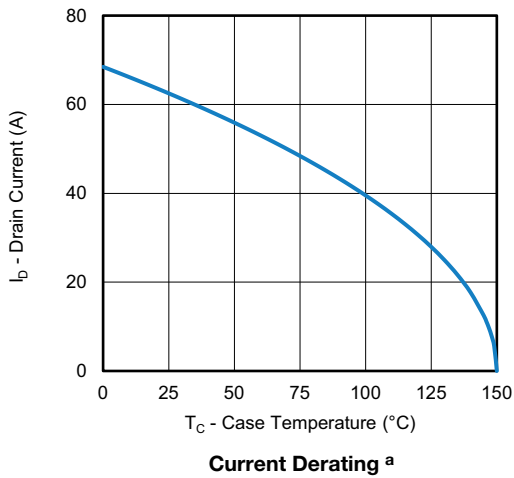
Safe Operating Area, Junction-to-Ambient

Note

a. $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified



CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

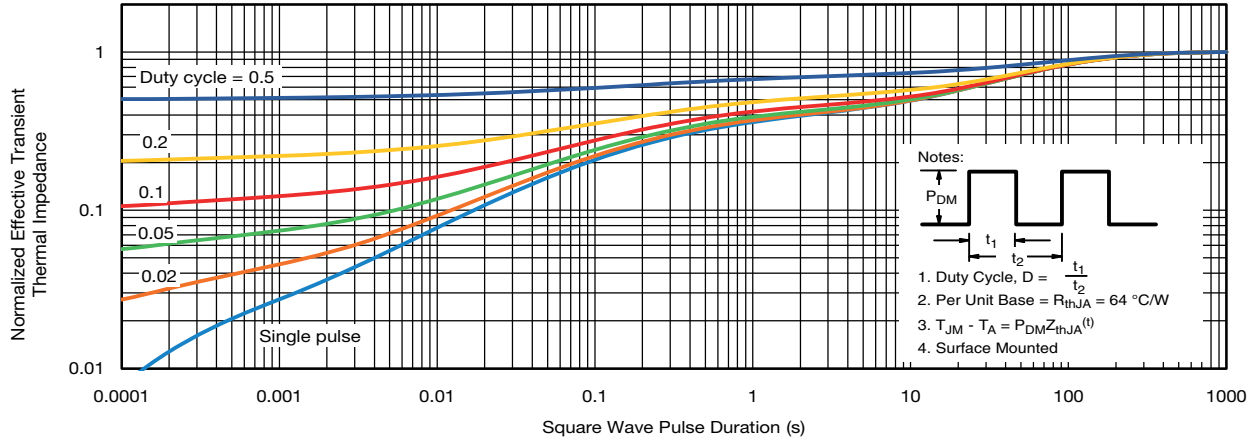


Note

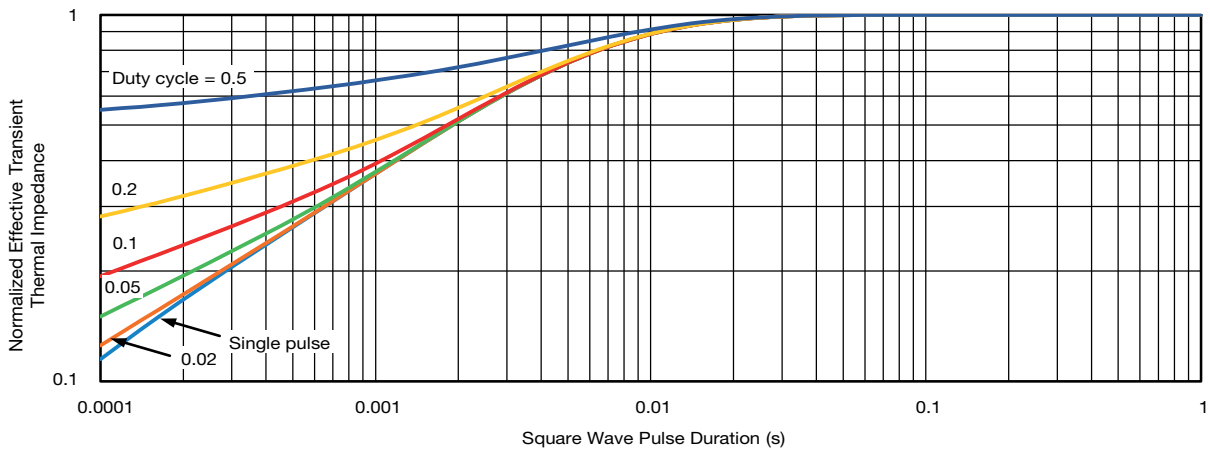
- a. The power dissipation P_D is based on T_J max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package / tape drawings, part marking, and reliability data, see www.vishay.com/ppg?61551.



Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Hyperlinks included in this datasheet may direct users to third-party websites. These links are provided as a convenience and for informational purposes only. Inclusion of these hyperlinks does not constitute an endorsement or an approval by Vishay of any of the products, services or opinions of the corporation, organization or individual associated with the third-party website. Vishay disclaims any and all liability and bears no responsibility for the accuracy, legality or content of the third-party website or for that of subsequent links.

Vishay products are not designed for use in life-saving or life-sustaining applications or any application in which the failure of the Vishay product could result in personal injury or death unless specifically qualified in writing by Vishay. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.